



## DESCRIPTION

The AM4920 is the Dual N-Channel logic enhancement mode power field effect transistor is produced using high cell density. Advanced trench technology to provide excellent  $R_{DS(ON)}$ .

This device is suitable for use as a load switch or in PWM and gate charge for most of the synchronous buck converter applications.

The AM4920 is available in SOP8 package.

## ORDERING INFORMATION

Package Type	Part Number	
SOP8 SPQ: 2,500pcs/Reel	M8	AM4920M8R
		AM4920M8VR
Note	V: Halogen free Package R: Tape & Reel	
AiT provides all RoHS products		

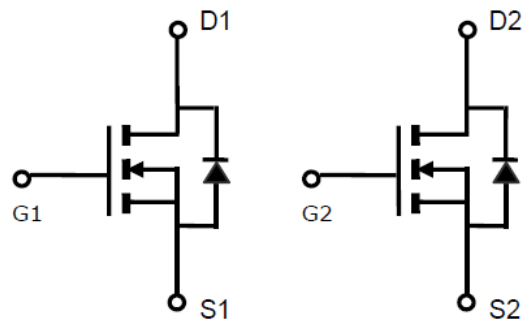
## FEATURES

- 30V / 7.8A,  $R_{DS(ON)} = 16m\Omega$  (typ.)@ $V_{GS}=10V$
- 30V / 5.8A,  $R_{DS(ON)} = 24m\Omega$  (typ.)@ $V_{GS}=4.5V$
- Super high density cell design for extremely low  $R_{DS(ON)}$
- Exceptional on-resistance and Maximum DC current capability
- Available in SOP8 package

## APPLICATIONS

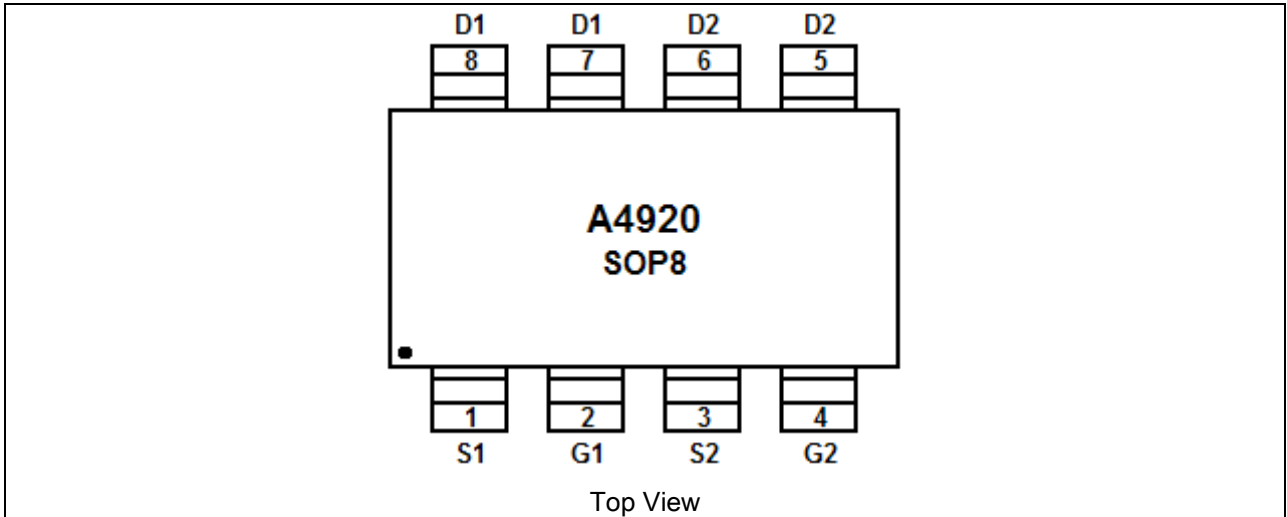
- High Frequency Point-of-Load Synchronous
- New working DC-DC Power System
- Load Switch

## N- CHANNEL MOSFET





## PIN DESCRIPTION



Pin #	Symbol	Function
1	S1	Source 1
2	G1	Gate 1
3	S2	Source 2
4	G2	Gate 2
5	D2	Drain 2
6	D2	Drain 2
7	D1	Drain 1
8	D1	Drain 1



## ABSOLUTE MAXIMUM RATINGS

T<sub>A</sub> = 25°C, unless otherwise specified

V <sub>DSS</sub> , Drain-Source Voltage		30V
V <sub>GSS</sub> , Gate-Source Voltage		±20V
I <sub>D</sub> , Continuous Drain Current, V <sub>GS</sub> =10V <sup>NOTE1</sup>	T <sub>A</sub> =25°C	7.8A
	T <sub>A</sub> =70°C	6.5A
I <sub>DM</sub> , Pulsed Drain Current <sup>NOTE2</sup>		25A
E <sub>AS</sub> , Single Pulse Avalanche Energy L=0.1mH <sup>NOTE3</sup>		27mJ
I <sub>AS</sub> , Avalanche Current		14A
P <sub>D</sub> , Power Dissipation	T <sub>A</sub> =25°C	2.0W
	T <sub>A</sub> =70°C	1.4W
T <sub>J</sub> , Operation Junction Temperature		-55°C~150°C
T <sub>STG</sub> , Storage Temperature Range		-55°C~150°C

Stress beyond above listed "Absolute Maximum Ratings" may lead permanent damage to the device. These are stress ratings only and operations of the device at these or any other conditions beyond those indicated in the operational sections of the specifications are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## THERMAL INFORMATION

Parameter		Symbol	Max	Unit
Thermal Resistance-Junction to Ambient <sup>NOTE1</sup>	Steady-State	R <sub>θJA</sub>	85	°C/W
Thermal Resistance Junction to Lead <sup>NOTE1</sup>	Steady-State	R <sub>θJC</sub>	50	°C/W



## ELECTRICAL CHARACTERISTICS

T<sub>A</sub> = 25°C, unless otherwise specified

Parameter	Symbol	Conditions	Min	Type	Max	Units
<b>Static Parameters</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	30	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0	-	2.5	V
Gate Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V	-	-	±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V T <sub>J</sub> =25°C	-	-	1	μA
		V <sub>DS</sub> =24V, V <sub>GS</sub> =0V T <sub>J</sub> =55°C	-	-	5	
Drain-source On-Resistance <sup>NOTE2</sup>	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =7.8A	-	16	20	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =5.8A	-	24	30	
Forward Transconductance	g <sub>FS</sub>	V <sub>DS</sub> =10V, I <sub>D</sub> =6A	-	5.6	-	S
<b>Source-Drain Diode</b>						
Diode Forward Voltage <sup>NOTE2</sup>	V <sub>SD</sub>	I <sub>S</sub> =1.7A, V <sub>GS</sub> =0V	-	0.75	1.0	V
Continuous Source Current <sup>NOTE1,4</sup>	I <sub>S</sub>		-	-	5.8	A
<b>Dynamic Parameters</b>						
Total Gate Charge	Q <sub>g</sub> (4.5V)	V <sub>DS</sub> =15V, V <sub>GS</sub> =4.5V, I <sub>D</sub> =5.8A	-	5	7.2	nC
Gate-Source Charge	Q <sub>gs</sub>		-	1.6	-	
Gate-Drain Charge	Q <sub>gd</sub>		-	1.9	-	
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz	-	420	586	pF
Output Capacitance	C <sub>oss</sub>		-	65	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	52	-	
Turn-On Time	t <sub>d(on)</sub>	V <sub>DD</sub> =15V, V <sub>GEN</sub> =10V, R <sub>G</sub> =3.3Ω	-	2.2	4.4	nS
	t <sub>r</sub>		-	38.7	68.8	
Turn-Off Time	t <sub>d(off)</sub>		-	12.5	25	
	t <sub>f</sub>		-	4.8	9.6	

NOTE1: The value of R<sub>θJA</sub> is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.

NOTE2: The data tested by pulsed , pulse width ≤300uS , duty cycle ≤2%

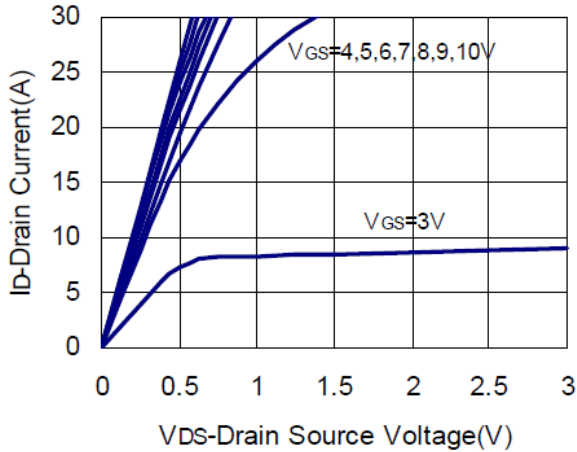
NOTE3: The EAS data shows Max. rating. The test condition is V<sub>DD</sub>=25V, V<sub>GS</sub>=10V, L=0.1mH.

NOTE4: The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.

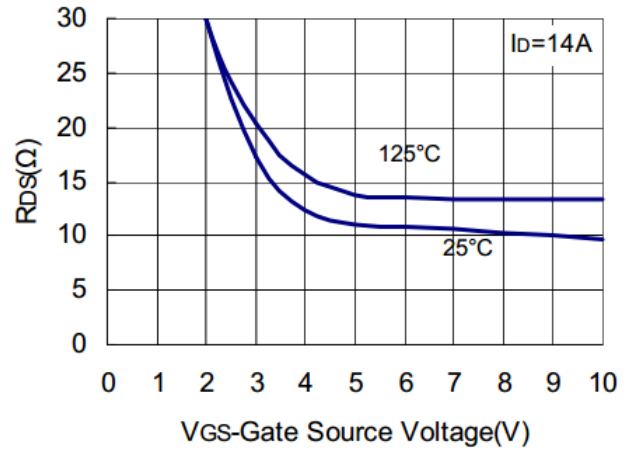


## TYPICAL CHARACTERISTICS

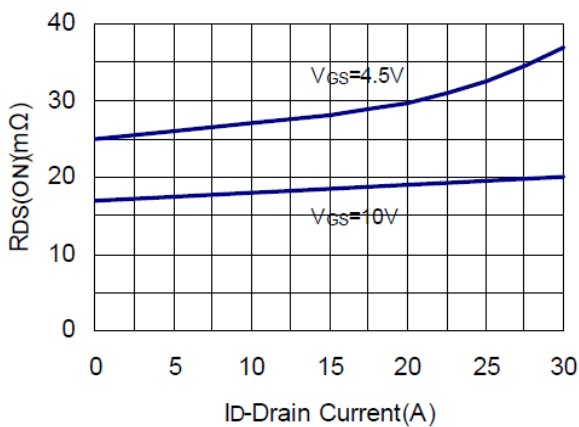
### 1. Output Characteristics



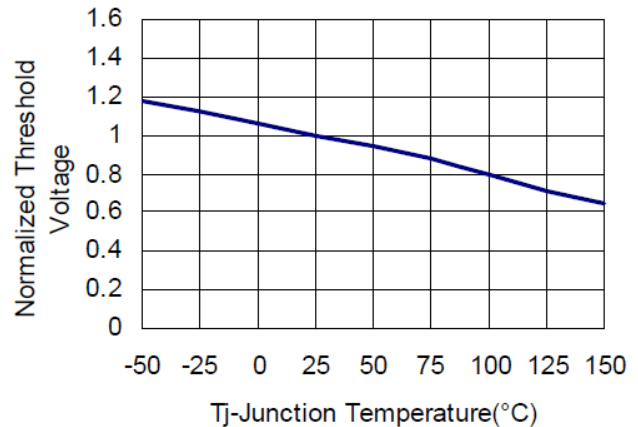
### 2. On Resistance vs. Gate Source Voltage



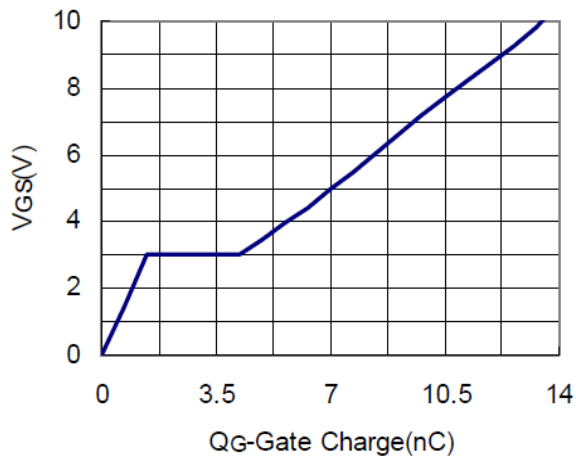
### 3. Drain Source On Resistance



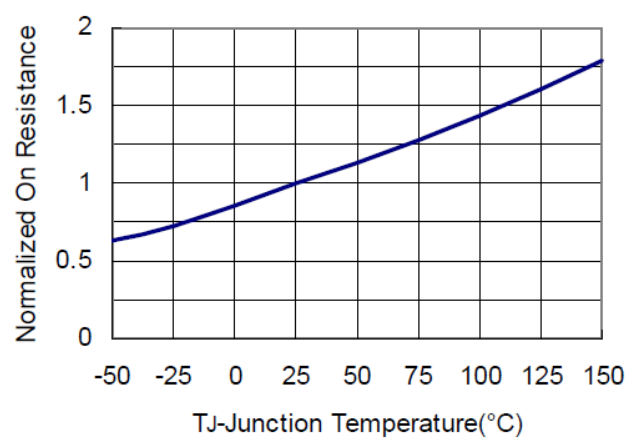
### 4. Gate Threshold Voltage



### 5. Gate Charge

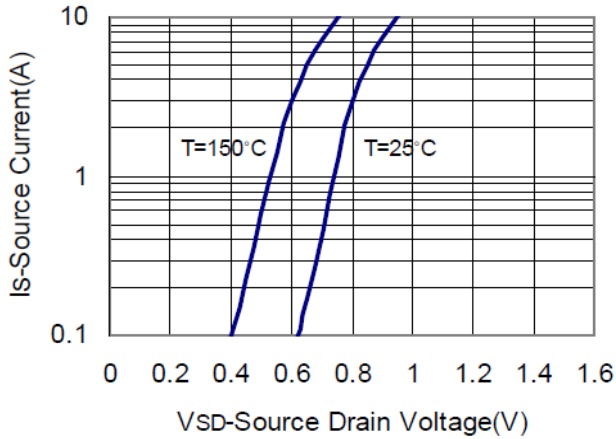


### 6. Drain Source On Resistance

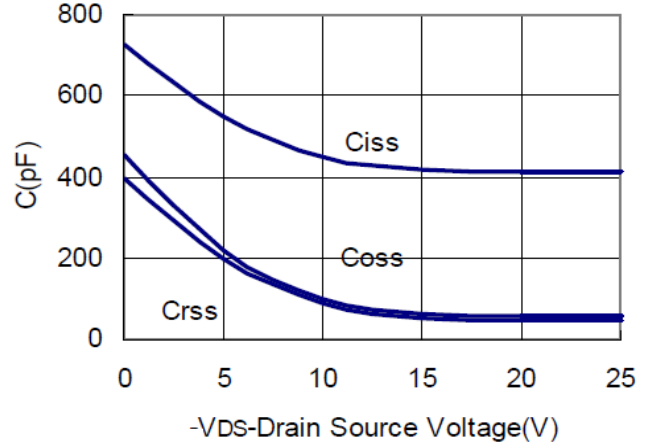




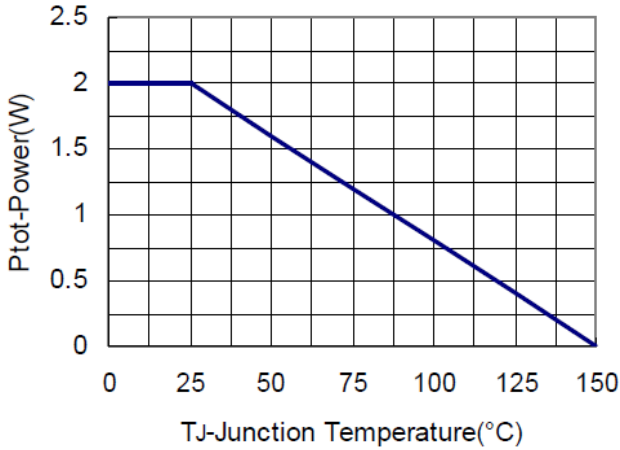
7. Source Drain Diode Forward



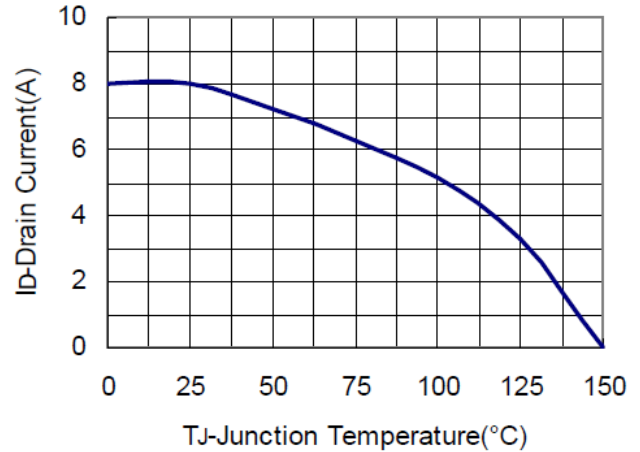
8. Capacitance



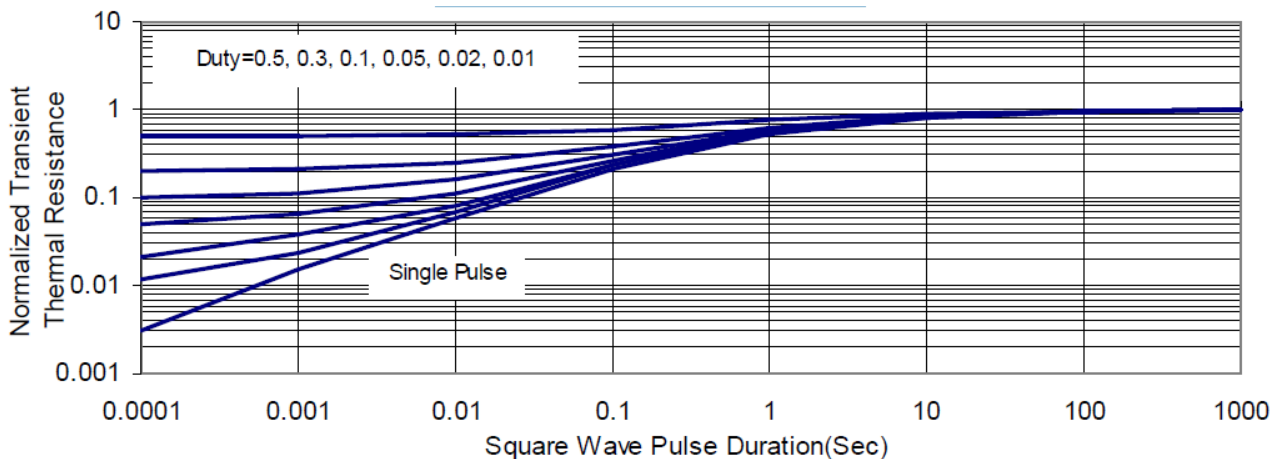
9. Power Dissipation



10. Drain Current



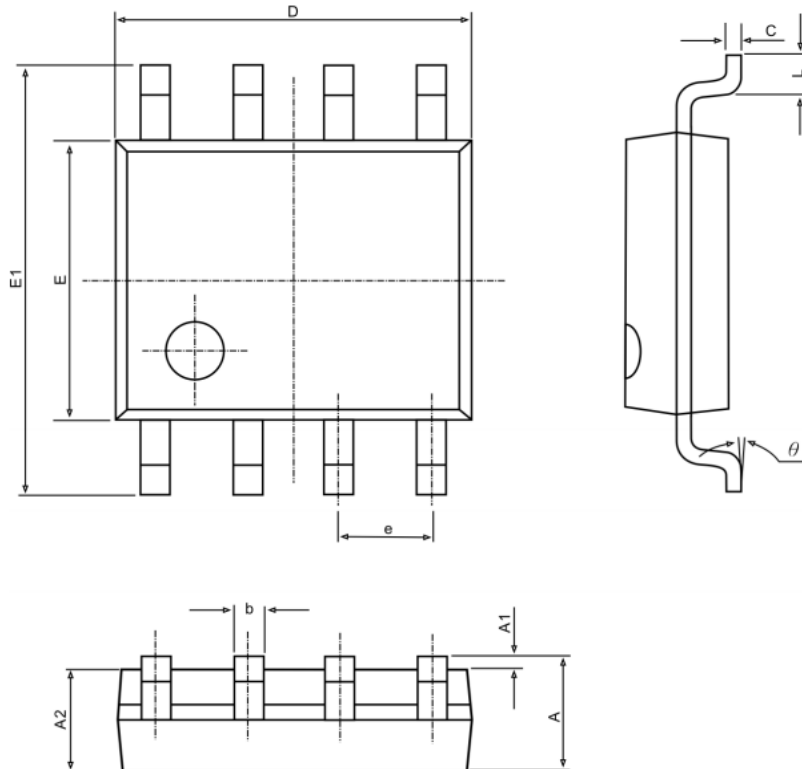
11. Thermal Transient Impedance





**PACKAGE INFORMATION**

Dimension in SOP8 (Unit: mm)



Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.040	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.288	0.244
e	1.270 BSC		0.050 BSC	
L	0.400	1.270	0.016	0.050
theta	0°	8°	0°	8°



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